

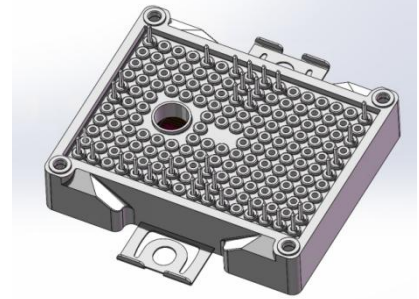
JL3I150V65SE2F7SN

3-Level NPC Inverter Module with 650V Trench Stop IGBTs

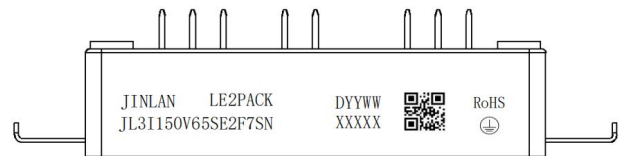


Features

- Electrical features
 - 650V Trench Stop IGBTs
 - Low Inductive Design
 - Low Switching Losses
 - Low Inductive Layout
 - Thermistor
- Mechanical features
 - Compact Design
 - Solderable Pins
 - Al₂O₃ Substrate with Low Thermal Resistance



LE2 Pack



Typical Applications

- 3-Level-Applications
- Solar Applications
- UPS Systems

JINLAN

JL3I150V65SE2F7SN

YYWW

XXXXX

QR code

= Company Name

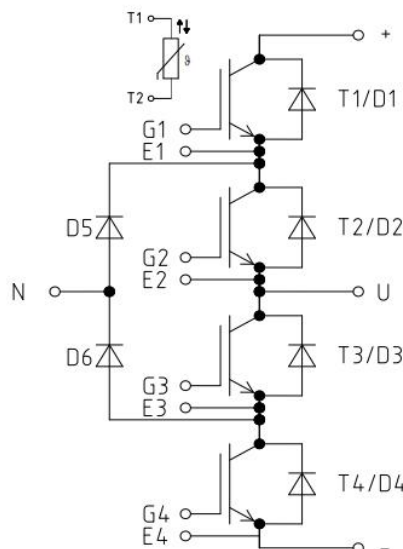
= Specific Device Code

= Year and Work Week Code

= Serial Number

= Custom Assembly Information

Description





Package Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V_{ISOL}	RMS,f=50Hz,t=60s	2.5	kV
Internal isolation		basic insulation(class 1,IEC 61140)	Al_2O_3	
Creepage distance	d_{creep}	terminal to heatsink	11.5	mm
Clearance	d_{clear}	terminal to heatsink	10	mm
Comparative tracking index (electrical)	CTI		>200	
RTI Elec.	RTI	housing	140	°C

Package Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Stray Inductance	LCE			--	15	--	nH
Module Lead Resistance, Terminal to Chip	RCC'+EE'			--	2	--	mΩ
Storage Temperature Range	T _{STG}			-40	--	125	°C
Mounting torque for module mounting	M	-Mounting according to valid application note		40	--	80	N
Weight	G			--	39	--	g

**IGBT****Absolute Maximum Ratings** ($T_c = 25^\circ\text{C}$ unless otherwise noted) (**T1、T2、T3、T4**)

Symbol	Description	Value	Unit
V_{CES}	Collector-Emitter Voltage	650	V
V_{GES}	Gate-Emitter Voltage	± 30	V
I_{CDC}	Continuous Collector Current @ $T_c = 80^\circ\text{C}$ ($T_{JMAX} = 175^\circ\text{C}$)	150	A
I_{CM}	Pulsed Collector Current, t_p limited by $T_{vj\max}$	300	A
P_D	Power Dissipation @ $T_c = 25^\circ\text{C}$	379	W
	Power Dissipation @ $T_c = 100^\circ\text{C}$	151	W

Characteristics ($T_c=25^\circ\text{C}$ unless otherwise noted) (**T1、T4**)

Symbol	Parameter	Test Condition		Min	Typ	Max	Unit
V _{CE(sat)}	Collector–Emitter Saturation Voltage	I _C =150A, V _{GE} = 15V	T _{vj} = 25 °C	--	1.35	1.90	V
			T _{vj} = 150°C	--	1.50	--	
V _{GE(TH)}	Gate–Emitter Threshold Voltage	I _C =3mA,V _{CE} =V _{GE}		4.0	--	5.5	V
I _{CES}	Collector–Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 650 V		--	--	200	μA
I _{GES}	Gate-Emitter Leakage Current	V _{GE} = ±30 V, V _{CE} = 0 V, T _{vj} = 25°C		--	--	± 100	nA
R _{Gint}	Internal Gate Resistance	T _{vj} = 25 °C		--	1.45	--	Ω
C _{ies}	Input Capacitance	V _{CE} =25V,V _{GE} =0V, f=1MHz		--	11900	--	pF
C _{oes}	Output capacitance			--	505	--	pF
C _{res}	Reverse Transfer			--	71.4	--	pF
Q _G	Gate Charge	V _{CE} = 400 V, I _C = 150 A V _{GE} = –5 V to +15 V T _{vj} = 25 °C		--	0.356	--	μC
t _{d(on)}	Turn–On Delay Time	V _{CE} =400V, I _C =150A, V _{GE} = –5 V to +15 V, R _G =25Ω Inductive Load T _{vj} = 25 °C		--	260	--	ns
t _r	Rise Time			--	50	--	
t _{d(off)}	Turn–off Delay Time			--	1280	--	
t _f	Fall Time			--	130	--	
E _{on}	Turn–On Switching Loss per Pulse			--	8.3	--	mJ
E _{off}	Turn Off Switching Loss per Pulse			--	15.3	--	
t _{d(on)}	Turn–On Delay Time	V _{CE} =400V, I _C =150A, V _{GE} = –5 V to +15 V, R _G =25Ω T _{vj} = 150 °C		--	350	--	ns
t _r	Rise Time			--	50	--	
t _{d(off)}	Turn–off Delay Time			--	1270	--	
t _f	Fall Time			--	190	--	
E _{on}	Turn–on Switching Loss per Pulse					--	12.4
E _{off}	Turn Off Switching Loss per Pulse			--	14.7	--	
R _{thJC}	Thermal resistance	Junction-to-Case (per IGBT)		--	0.294	--	K/W
T _{vj op}		Temperature under switching conditions		–40		175 ¹⁾	°C

¹⁾ $T_{vj\text{ op}} > 150^\circ\text{C}$ is only allowed for operation at overload conditions.

**Characteristics** (T_c=25°C unless otherwise noted) (T₂、T₃)

Symbol	Parameter	Test Condition		Min	Typ	Max	Unit
V _{CE(sat)}	Collector–Emitter Saturation Voltage	I _C =150A, V _{GE} = 15V	T _{vj} = 25 °C	--	1.35	1.90	V
			T _{vj} = 150°C	--	1.50	--	
V _{GE(TH)}	Gate–Emitter Threshold Voltage	I _C =3mA,V _{CE} =V _{GE}		4.0	--	5.5	V
I _{CES}	Collector–Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 650 V		--	--	200	μA
I _{GES}	Gate-Emitter Leakage Current	V _{GE} = ±30 V, V _{CE} = 0 V, T _{vj} = 25°C		--	--	± 100	nA
R _{Gint}	Internal Gate Resistance	T _{vj} = 25 °C		--	1.45	--	Ω
C _{ies}	Input Capacitance	V _{CE} =25V,V _{GE} =0V, f=1MHz		--	11900	--	pF
C _{oes}	Output capacitance			--	505	--	pF
C _{res}	Reverse Transfer			--	71.4	--	pF
Q _G	Gate Charge	V _{CE} = 400 V, I _C = 150 A V _{GE} = -5 V to +15 V T _{vj} = 25 °C		--	0.356	--	μC
t _{d(on)}	Turn–On Delay Time	V _{CE} =400V, I _C =150A, V _{GE} = -5 V to +15 V, R _G =25Ω Inductive Load T _{vj} = 25 °C		--	370	--	ns
t _r	Rise Time			--	40	--	
t _{d(off)}	Turn–off Delay Time			--	1190	--	
t _f	Fall Time			--	120	--	
E _{on}	Turn–On Switching Loss per Pulse			--	4.3	--	mJ
E _{off}	Turn Off Switching Loss per Pulse			--	12.6	--	
t _{d(on)}	Turn–On Delay Time	V _{CE} =400V, IC=150A, V _{GE} = -5 V to +15 V, R _G =25Ω T _{vj} = 150 °C		--	350	--	ns
t _r	Rise Time			--	50	--	
t _{d(off)}	Turn–off Delay Time			--	1220	--	
t _f	Fall Time			--	150	--	
E _{on}	Turn–on Switching Loss per Pulse			--	8.5	--	mJ
E _{off}	Turn Off Switching Loss per Pulse			--	11.3	--	
R _{thJC}	Thermal resistance	Junction-to-Case (per IGBT)		--	0.294	--	K/W
T _{vj op}		Temperature under switching conditions		-40		175 ²⁾	°C

²⁾T_{vj op} > 150°C is only allowed for operation at overload conditions.

Diode**Absolute Maximum Ratings** (T_c = 25°C unless otherwise noted) (D1、D2、D3、D4)

Symbol	Description	Value	Unit
V _{RRM}	Repetitive Peak Reverse Voltage	650	V
I _F	Diode Continuous Forward Current	150	A
I _{FM}	Diode Maximum Forward Current t _p =1ms	300	A

Characteristics (T_c=25°C unless otherwise noted) (D1、D4)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
V _F	Diode Forward Voltage	I _F = 150 A, T _{vj} = 25 °C	--	1.60	2.3	V
		I _F = 150 A, T _{vj} = 150°C	--	1.40	--	
T _{rr}	Reverse Recovery Time	V _{CE} =400V, V _{GE} = -5 V to +15 V, I _F =150A,R _G =25Ω , T _{vj} = 25 °C	--	164	--	ns
I _{RM}	Peak Reverse Recovery Current		--	79.04	--	A
Q _{rr}	Recovered Charge		--	5.73	--	μC



E_{rec}	Reverse Recovery Energy	$V_{CE}=400V,$ $V_{GE}= -5 V \text{ to } +15 V$ $I_F=150A, R_G=25\Omega,$ $T_{vj} = 150^\circ C$	--	1.6	--	mJ
T_{rr}	Reverse Recovery Time		--	259	--	ns
I_{RM}	Peak Reverse Recovery Current		--	91	--	A
Q_{rr}	Recovered Charge		--	13.9	--	μC
E_{rec}	Reverse Recovery Energy		--	3.25	--	mJ
R_{thJC}	Thermal resistance	Junction-to-Case (per diode)	--	0.319	--	K/W
$T_{vj op}$		Temperature under switching conditions	-40		175 ³⁾	$^\circ C$

³⁾ $T_{vj op} > 150^\circ C$ is only allowed for operation at overload conditions.

Characteristics (T_C=25 $^\circ C$ unless otherwise noted) (D2、D3)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
V_F	Diode Forward Voltage	$I_F = 150 A, T_{vj} = 25^\circ C$	--	1.60	2.3	V
		$I_F = 150 A, T_{vj} = 150^\circ C$	--	1.40	--	
T_{rr}	Reverse Recovery Time	$V_{CE}=400V,$ $V_{GE}= -5 V \text{ to } +15 V,$ $I_F=150A, R_G=25\Omega,$ $T_{vj} = 25^\circ C$	--	185	--	ns
I_{RM}	Peak Reverse Recovery Current		--	76.4	--	A
Q_{rr}	Recovered Charge		--	5.94	--	μC
E_{rec}	Reverse Recovery Energy		--	1.45	--	mJ
T_{rr}	Reverse Recovery Time	$V_{CE}=400V,$ $V_{GE}= -5 V \text{ to } +15 V$ $I_F=150A, R_G=25\Omega,$ $T_{vj} = 150^\circ C$	--	273	--	ns
I_{RM}	Peak Reverse Recovery Current		--	96.9	--	A
Q_{rr}	Recovered Charge		--	14.1	--	μC
E_{rec}	Reverse Recovery Energy		--	3.13	--	mJ
R_{thJC}	Thermal resistance	Junction-to-Case (per diode)	--	0.319	--	K/W
$T_{vj op}$		Temperature under switching conditions	-40		175 ⁴⁾	$^\circ C$

⁴⁾ $T_{vj op} > 150^\circ C$ is only allowed for operation at overload conditions.

Diode (D5、D6)

Absolute Maximum Ratings (T_C = 25 $^\circ C$ unless otherwise noted)

Symbol	Description	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	650	V
I_F	Diode Continuous Forward Current	150	A
I_{FM}	Diode Maximum Forward Current $t_p=1ms$	300	A

Characteristics (T_C=25 $^\circ C$ unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
V_F	Diode Forward Voltage	$I_F = 150 A, T_{vj} = 25^\circ C$	--	1.45	2.20	V
		$I_F = 150 A, T_{vj} = 175^\circ C$	--	1.25	--	
T_{rr}	Reverse Recovery Time	$V_{CE}=400V,$ $V_{GE}= -5 V \text{ to } +15 V$ $I_F=150A, R_G=25\Omega$ $T_{vj} = 25^\circ C$	--	158	--	ns
I_{RM}	Peak Reverse Recovery Current		--	85	--	A
Q_{rr}	Recovered Charge		--	5.58	--	μC
E_{rec}	Reverse Recovery Energy		--	1.25	--	mJ
T_{rr}	Reverse Recovery Time	$V_{CE}=400V,$ $V_{GE}= -5 V \text{ to } +15 V$ $I_F=150A, R_G=25\Omega,$ $T_{vj} = 150^\circ C$	--	279	--	ns
I_{RM}	Peak Reverse Recovery Current		--	92.7	--	A
Q_{rr}	Recovered Charge		--	14.88	--	μC
E_{rec}	Reverse Recovery Energy		--	2.65	--	mJ
R_{thJC}	Thermal resistance	Junction-to-Case (per diode)	--	0.2	--	K/W
$T_{vj op}$		Temperature under switching conditions	-40		175 ⁵⁾	$^\circ C$

⁵⁾ $T_{vj op} > 150^\circ C$ is only allowed for operation at overload conditions.



NTC Characteristics (Tc = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
R ₂₅	Rated Resistance		--	5.0	--	kΩ
ΔR/R	Deviation of R100	Tc=100 °C,R ₁₀₀ =493.3Ω	-5	--	5	%
P ₂₅	Power Dissipation		--	--	20.0	mW
B _{25/50}	B-value	$R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15K))]$	--	3375	--	K
B _{25/80}	B-value	$R_2=R_{25}\exp[B_{25/80}(1/T_2-1/(298.15K))]$	--	3411	--	K
B _{25/100}	B-value	$R_2=R_{25}\exp[B_{25/100}(1/T_2-1/(298.15K))]$	--	3433	--	K

Figure1.output characteristic IGBT,Inverter(typical)
 $T_{vj}=25^{\circ}\text{C}$

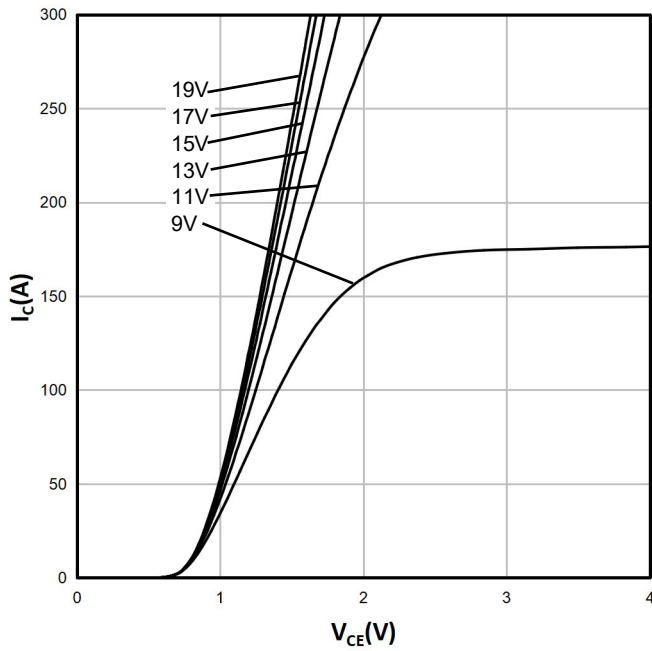


Figure2.output characteristic IGBT,Inverter(typical)
 $T_{vj}=150^{\circ}\text{C}$

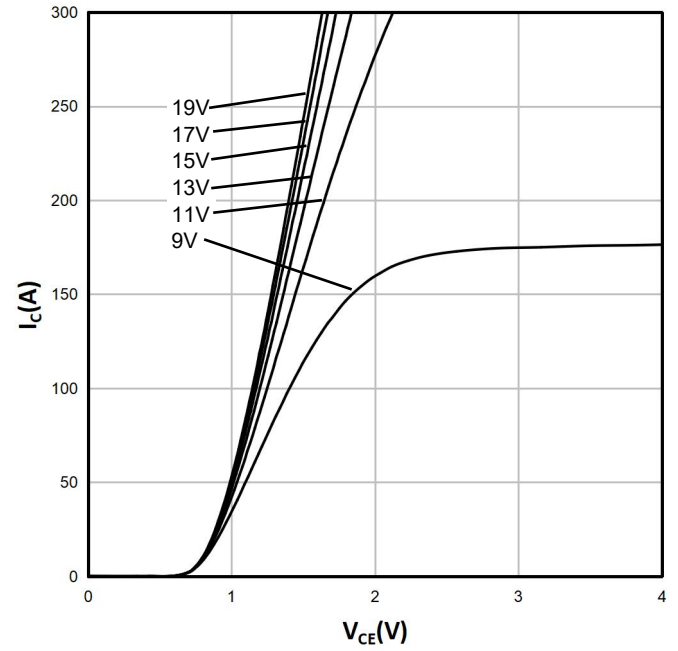


Figure3. $V_{CE(sat)}$ vs. Temperature

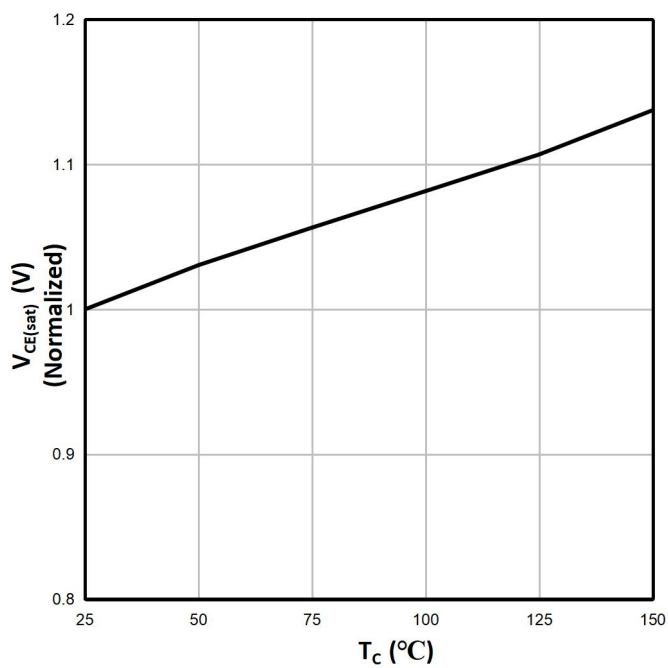


Figure4.transfer characteristic IGBT,Inverter(typical)
 $V_{CE}=20\text{V}$

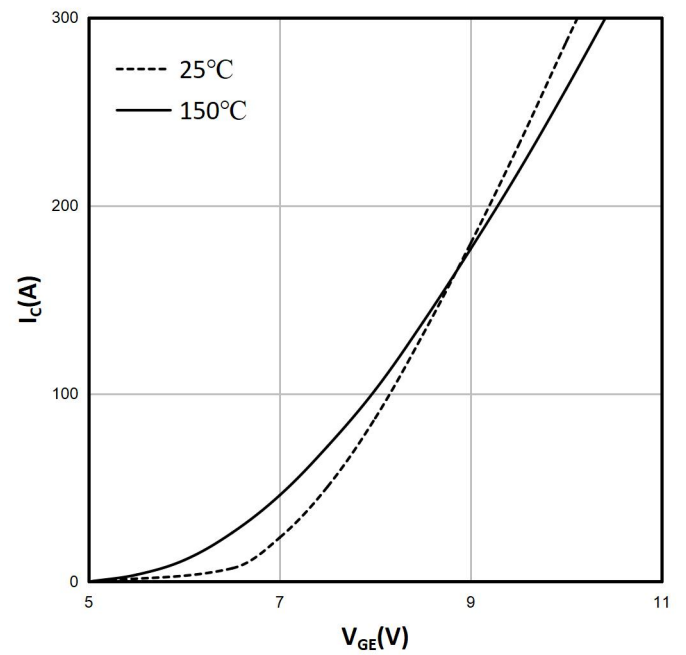


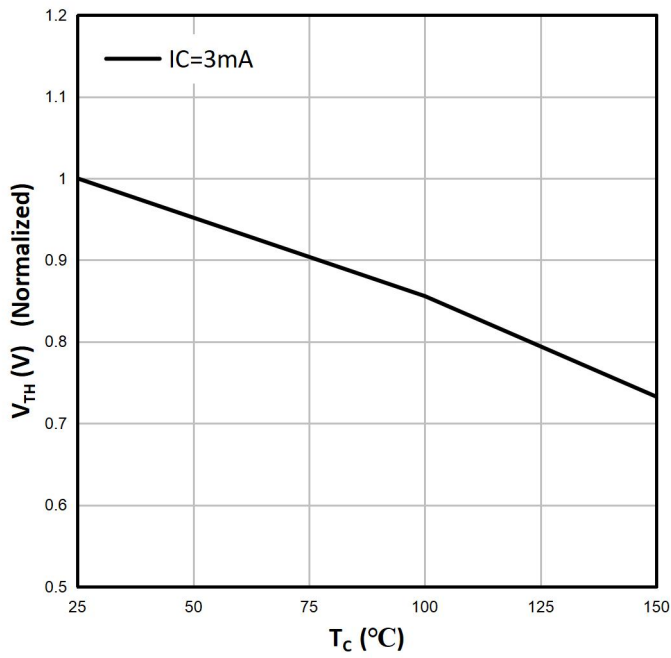
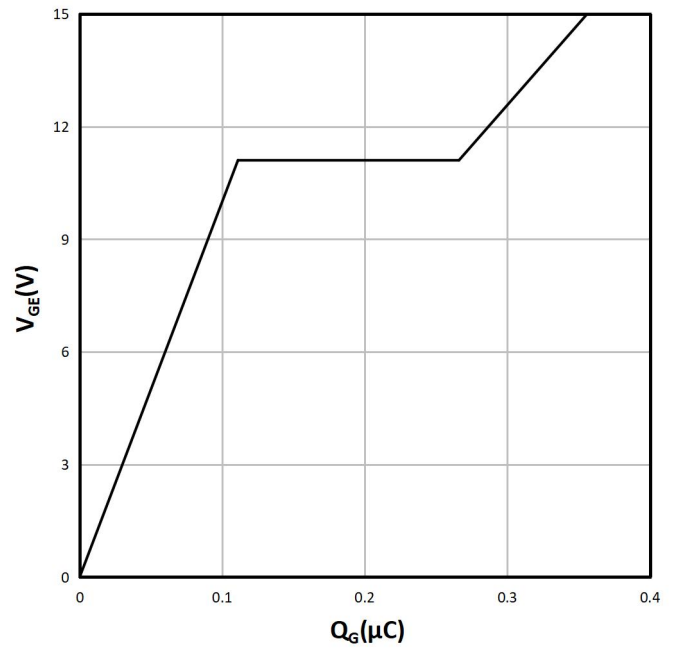
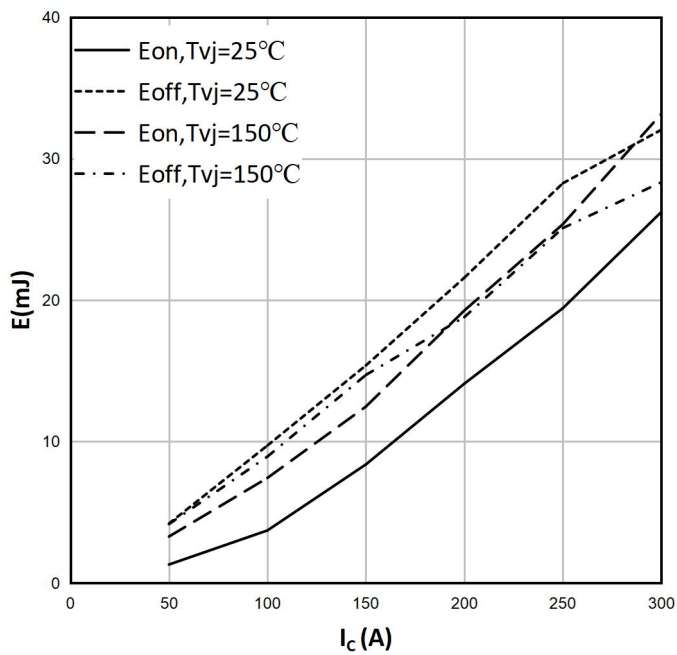
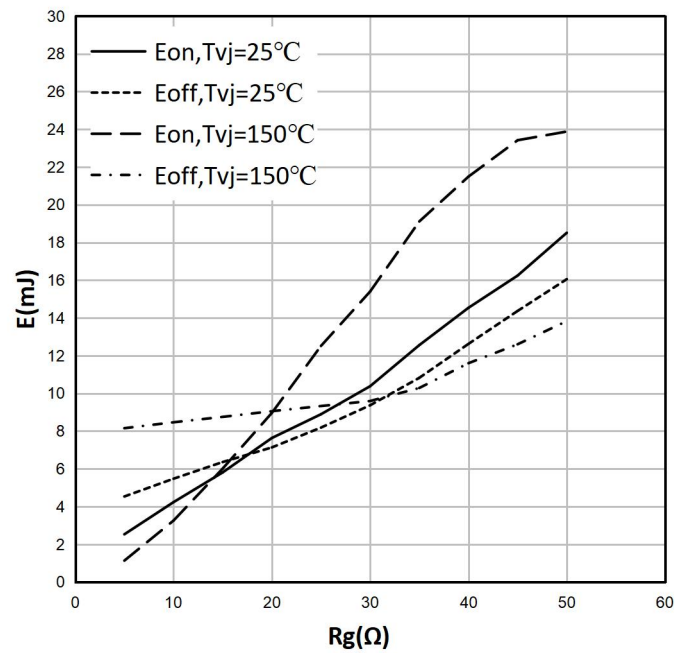
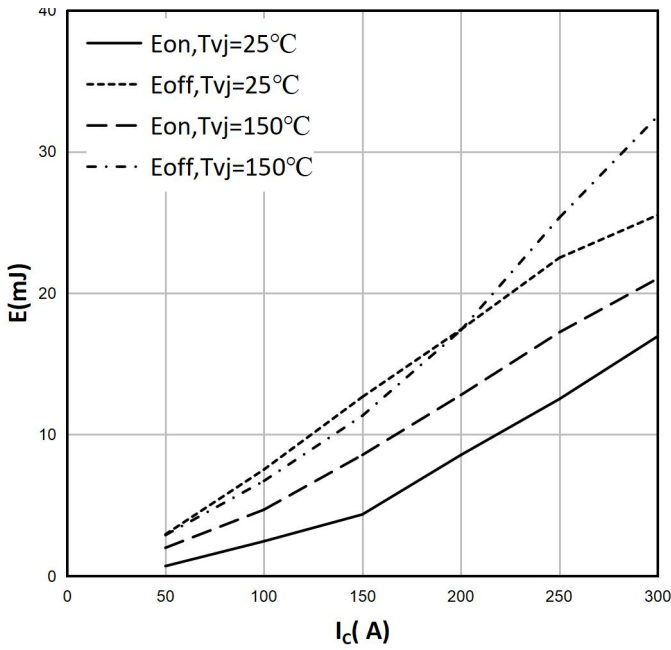
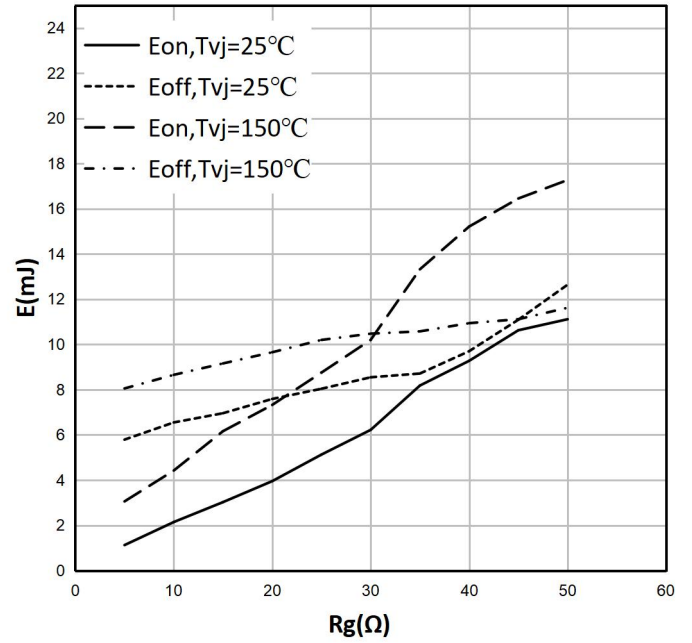
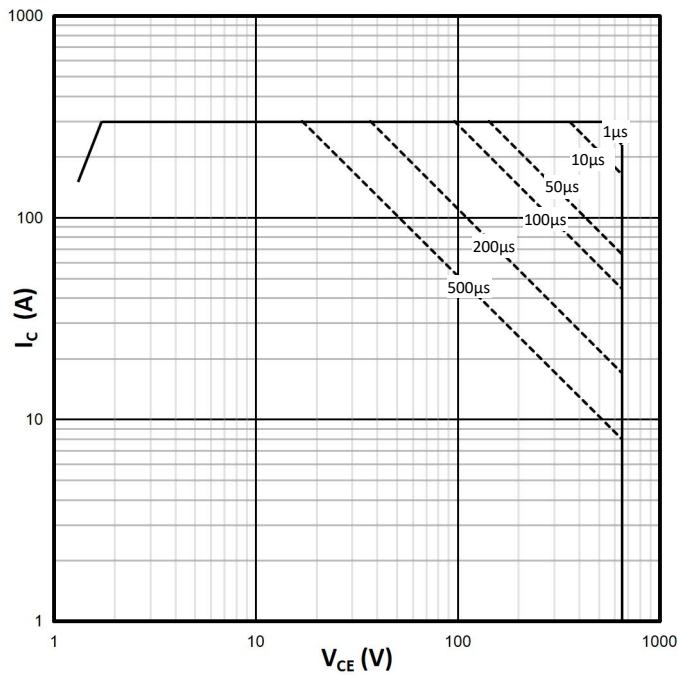
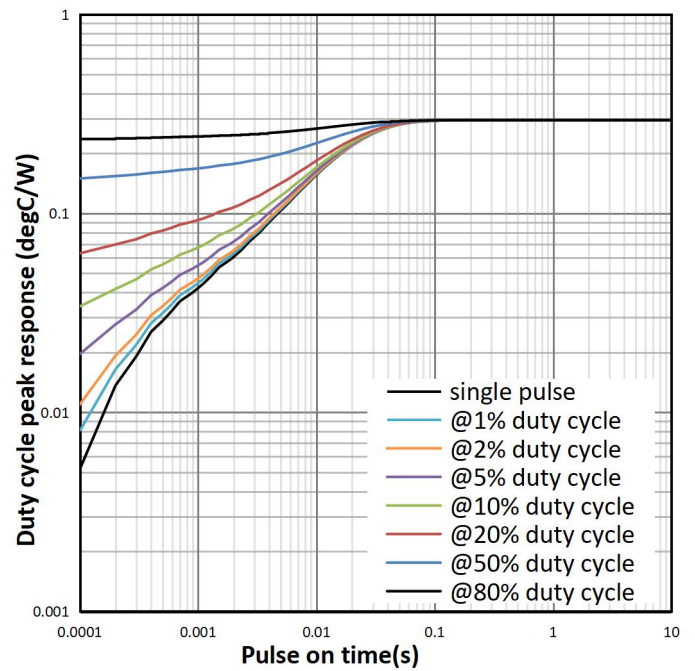
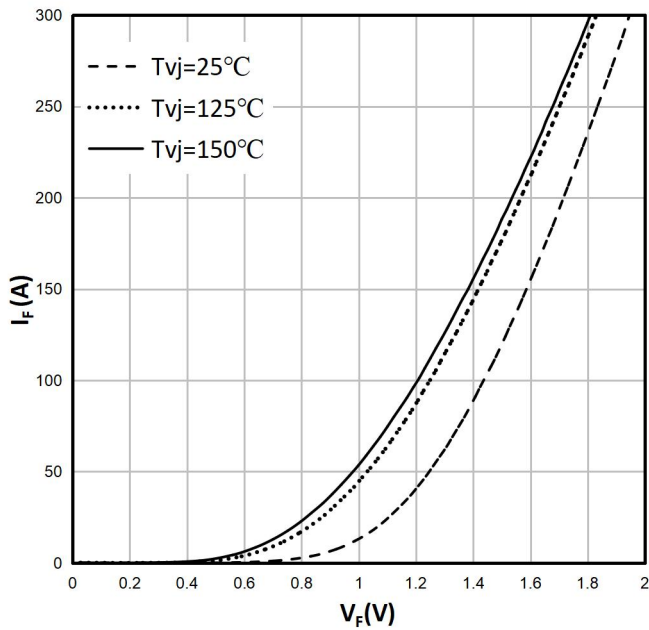
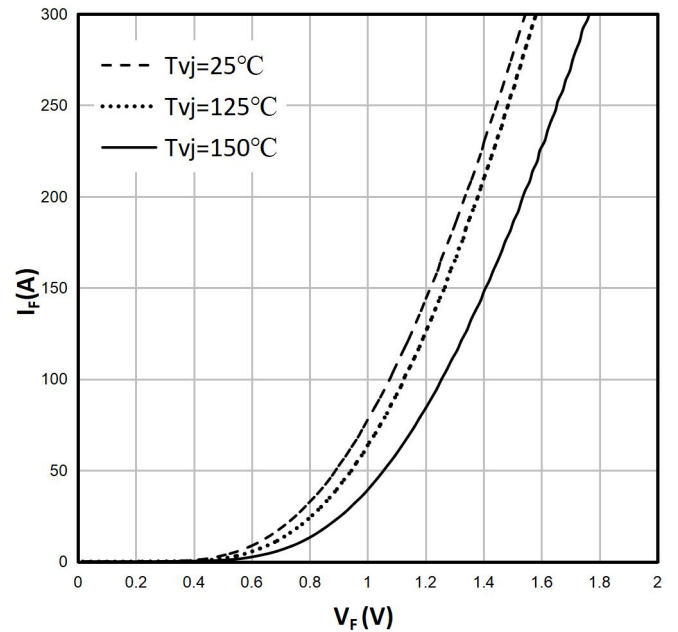
Figure5. V_{TH} vs. Temperature

Figure6. Gate Charge Waveform
 $V_{CC}=480V$

Figure7. switching losses IGBT, Inverter (typical) (T₁, T₄)
 $V_{CC}=400V, R_{gon}=25\Omega, R_{goff}=50\Omega, V_{ge}=15V/-5V$

Figure8. switching losses IGBT, Inverter (typical) (T₁, T₄)
 $V_{CC}=400V, I_C=150A, V_{ge}=15V/-5V$


Figure9.switching losses IGBT,Inverter(typical) (T2, T3)
 $V_{cc}=400V, R_{gon}=25\Omega, R_{goff}=50\Omega, V_{ge}=15V/-5V$

Figure10.switching losses IGBT,Inverter(typical) (T2, T3)
 $V_{cc}=400V, I_C=150A, V_{ge}=15V/-5V$

Figure11. FBSOA
IGBT,Inverter(typical) (T1, T2, T3, T4)
 $D=0, T_c=25^\circ C, T_j \leq 175^\circ C, V_{ge}=15V$

Figure12. transient thermal impedance
IGBT,Inverter(typical) (T1, T2, T3, T4)


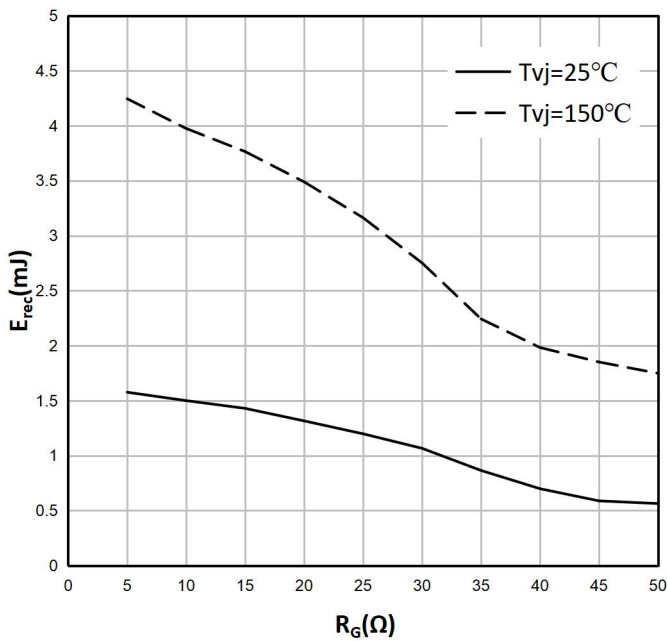
**Figure13. forward characteristic of Diode,Inverter(typical)
(D1, D2, D3, D4)**

 $V_{GE}=0V$


**Figure14. forward characteristic of Diode,Inverter(typical)
(D5, D6)**

 $V_{GE}=0V$


**Figure15.Reverse Recovery Energy Loss vs. R_G
(D1, D4)**

 $V_{CC}=400V, I_C=150A, V_{GE}=15V/-5V$


**Figure16.Reverse Recovery Energy Loss vs. I_C
(D1, D4)**

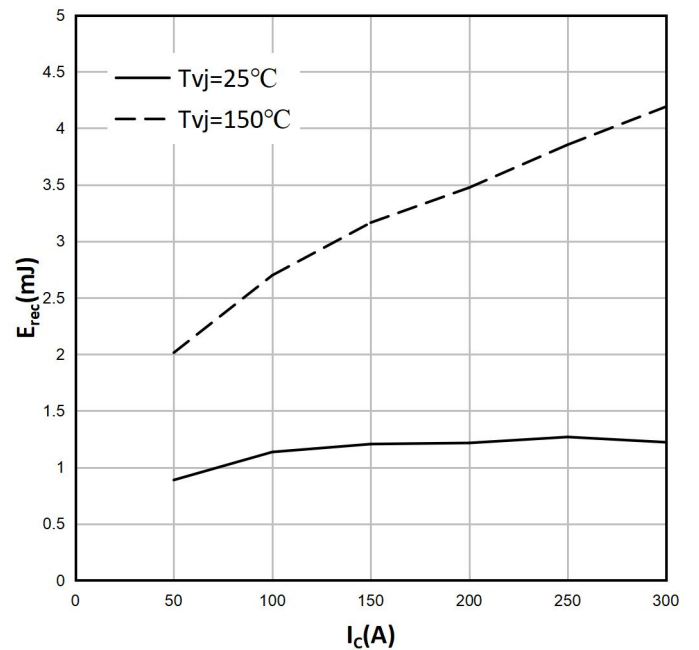
 $V_{CC}=400V, R_G=25\Omega, V_{GE}=15V/-5V$


Figure17.Reverse Recovery Energy Loss vs. R_G (D2, D3)

$V_{cc}=400V, I_C=150A, V_{ge}=15V/-5V$

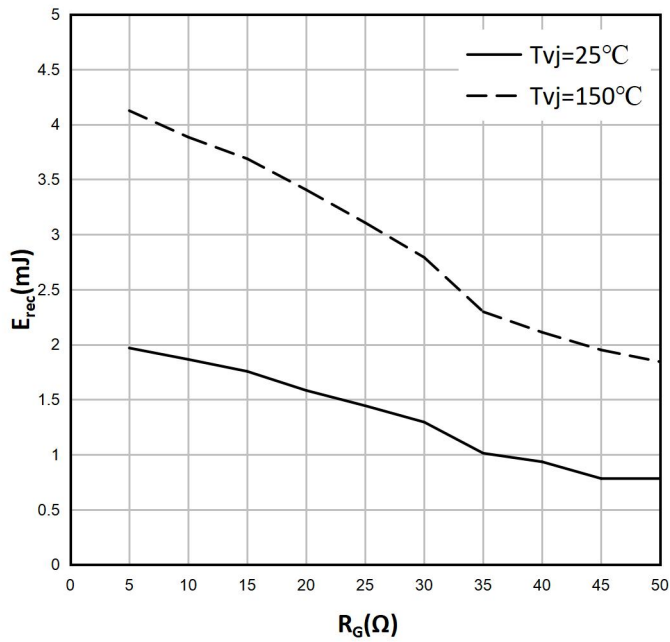


Figure18.Reverse Recovery Energy Loss vs. I_C (D2, D3)

$V_{cc}=400V, R_g=25\Omega, V_{ge}=15V/-5V$

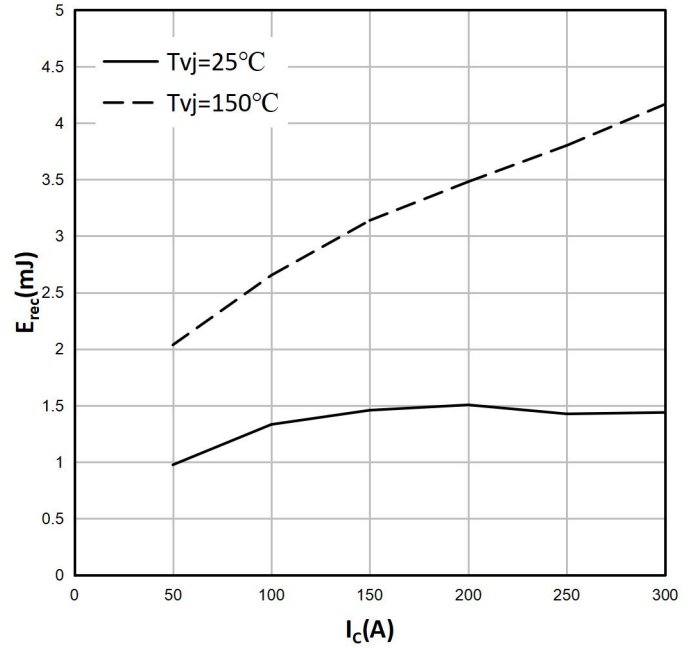


Figure19.Reverse Recovery Energy Loss vs. R_G (D5, D6)

$V_{cc}=400V, I_C=150A, V_{ge}=15V/-5V$

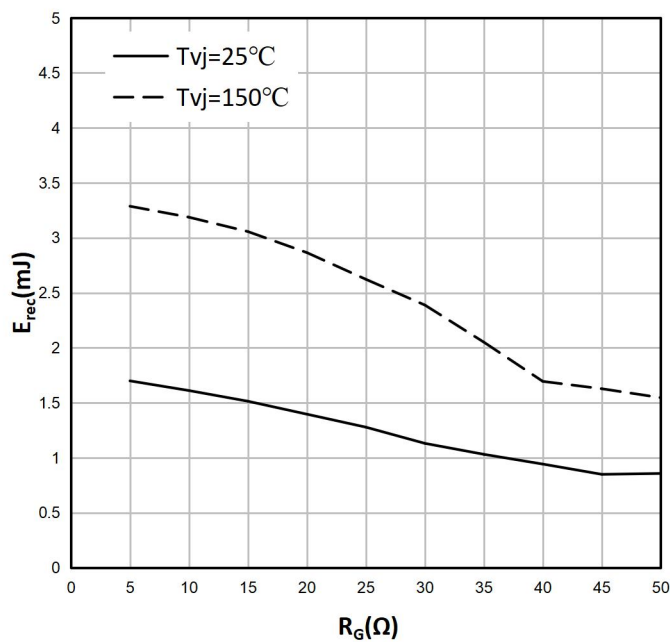
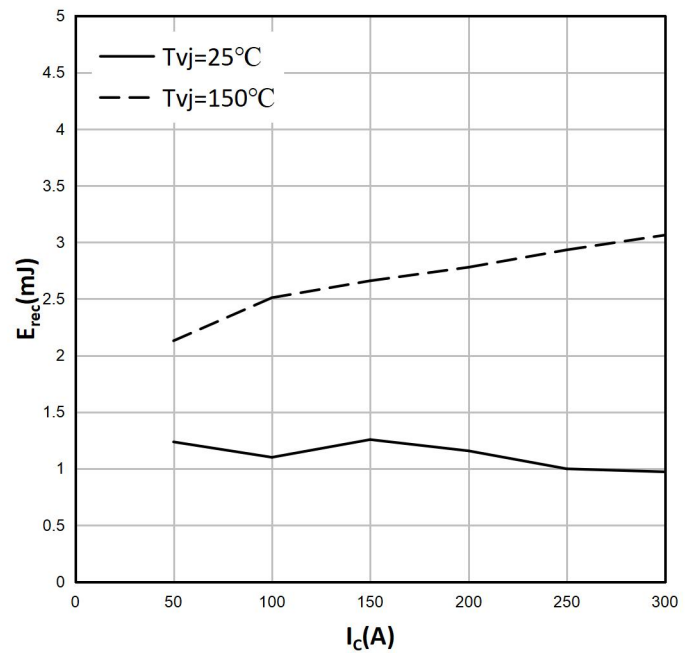
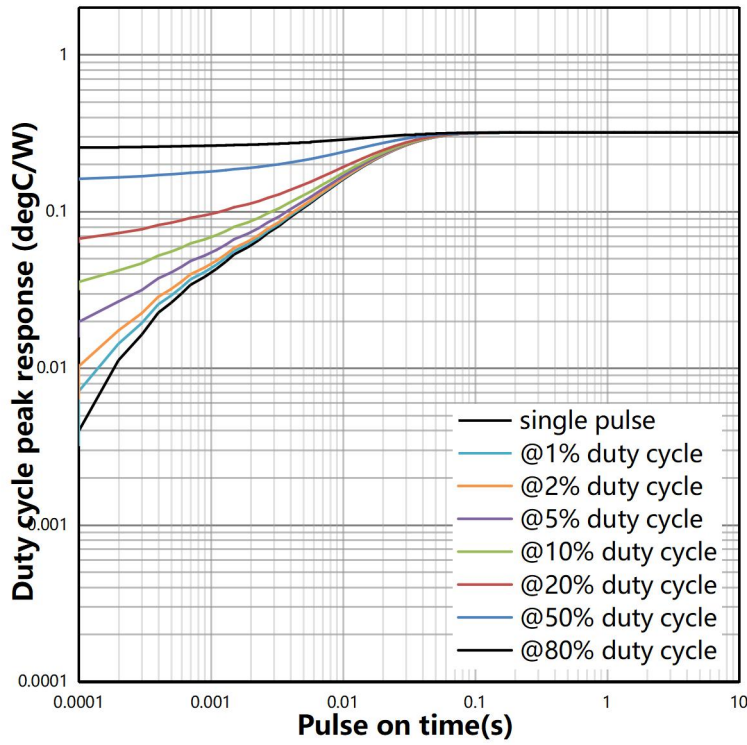


Figure20.Reverse Recovery Energy Loss vs. I_C (D5, D6)

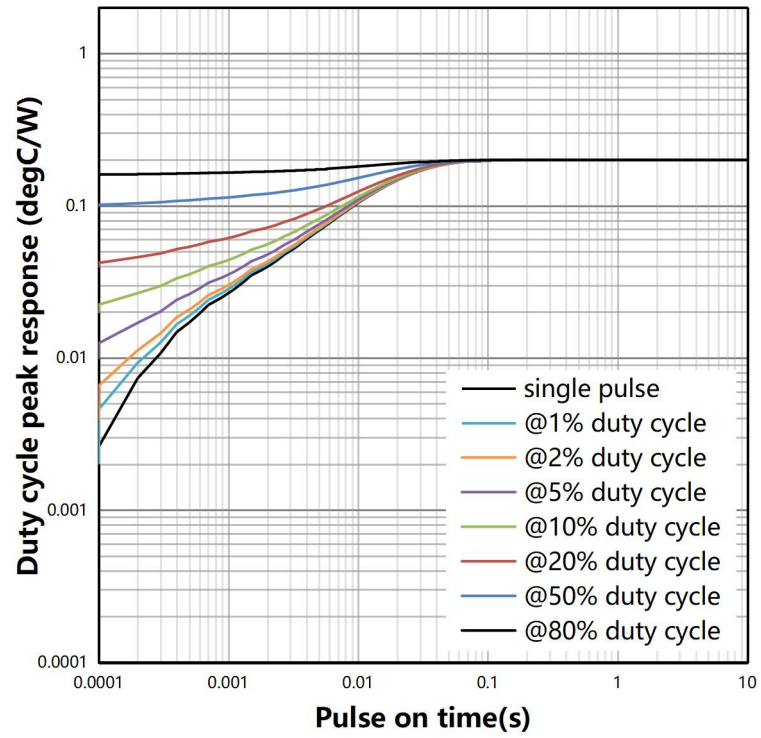
$V_{cc}=400V, R_g=25\Omega, V_{ge}=15V/-5V$



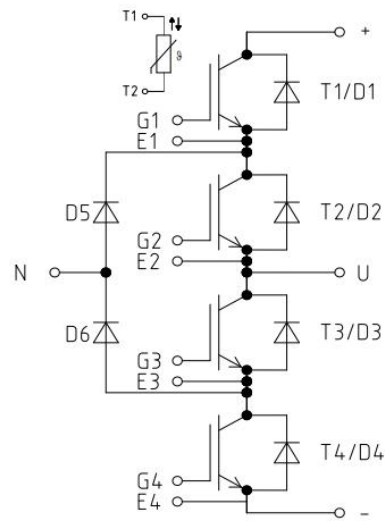
**Figure21. transient thermal impedance-FRD
(D1, D2, D3, D4)**



**Figure22. transient thermal impedance-FRD
(D5, D6)**

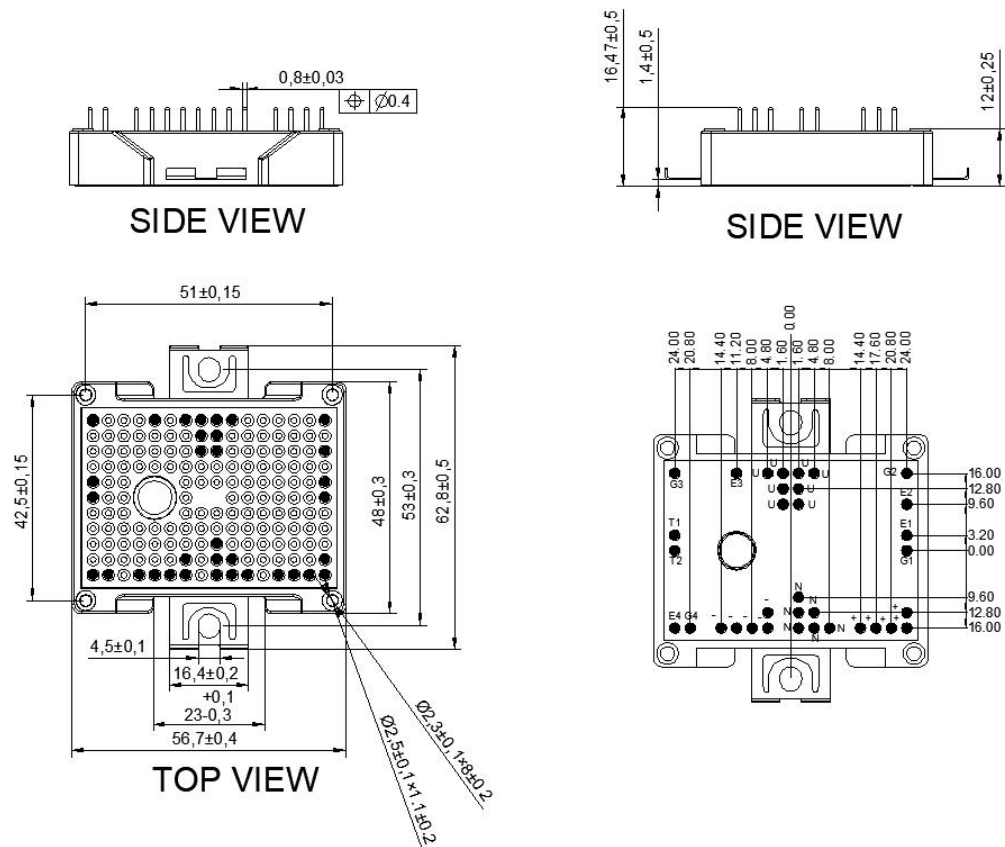


CIRCUIT DIAGRAM



PACKAGE DIMENSION

Dimensions in Millimeters





REVISION HISTORY

Document version	Date of release	Description of changes
Rev.00	2024-09-07	Preview
Rev.01	2025-02-17	Add Chart



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